

Open-Collector Output Optocoupler in 15-mm Stretched SO8 Package

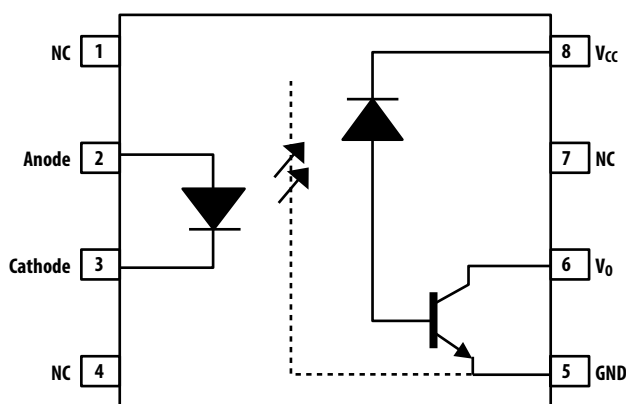
Data Sheet

Description

The ACNT-H511 is a single-channel open-collector output optocoupler in Stretched SO8 footprint. It uses an insulating layer between the light emitting diode and an integrated photon detector to provide electrical insulation between input and output. Separate connections for the photodiode bias and output transistor collector increase the speed up to a hundred times over that of a conventional photo-transistor coupler by reducing the base-collector capacitance.

The ACNT-H511 with 15-mm creepage/clearance and high voltage insulation capability is suitable for isolated communication logic interface and control in high-voltage power systems such as 690V_{AC} drives, renewable inverters, and medical equipment.

Functional Diagram



Truth Table

LED	OUTPUT
ON	L
OFF	H

A 0.1- μ F bypass capacitor must be connected between pins V_{CC} and GND.

Features

- TTL compatible
- Package: 15-mm stretched SO8 package
- Open-Collector Output
- 40 kV/ μ s typical common-mode rejection at V_{CM} = 1500V
- Guaranteed performance within temperature range: -40°C to +105°C
- Worldwide safety approval:
 - UL1577 recognized: 7500V_{rms} for 1 minute
 - CSA approval
 - IEC 60747-5-5 approval for reinforced insulation

Applications

- High voltage power systems, for example, 690V_{AC} drives
- Renewable energy inverters
- Feedback elements in switching power supplies
- Digital isolation for A/D, D/A conversion digital field
- Communications interface
- MCU interface

CAUTION

It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation that may be induced by ESD. The components featured in this data sheet are not to be used in military or aerospace applications or environments.

Ordering Information

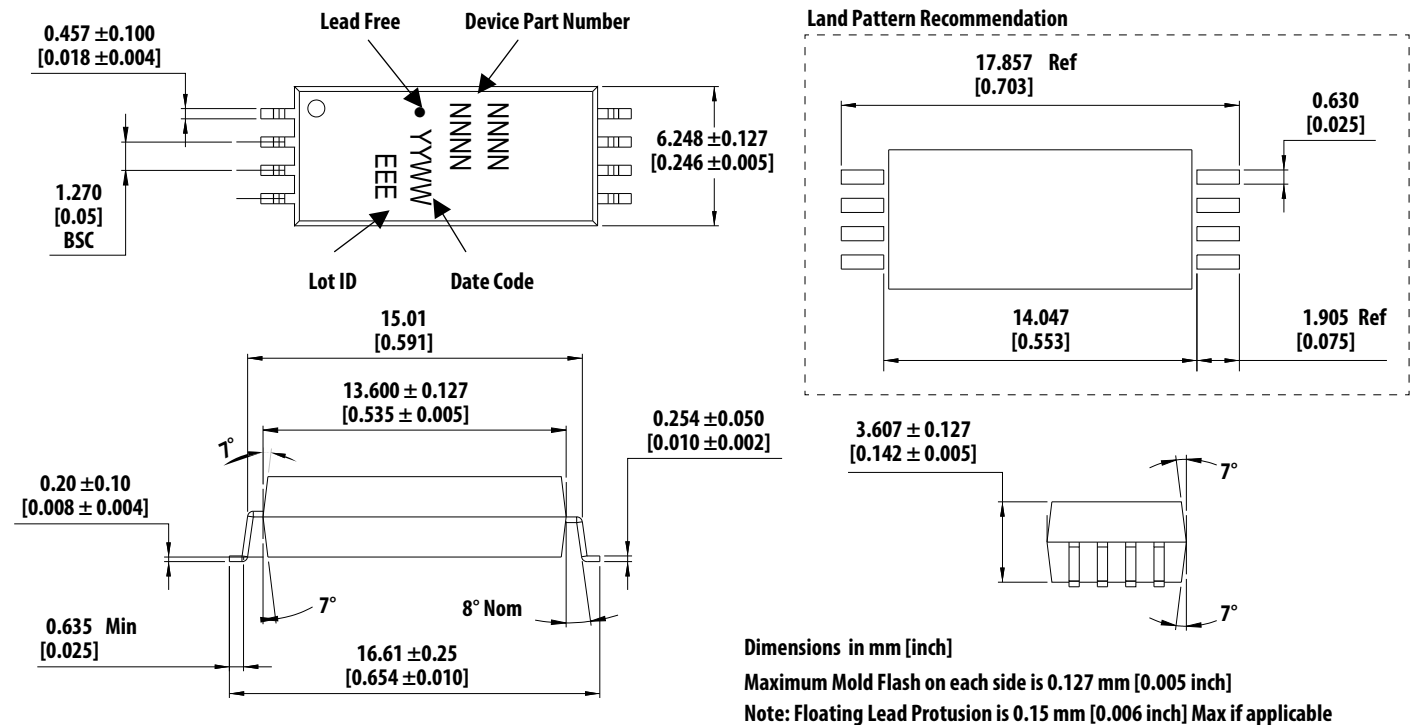
ACNT-H511 is UL Recognized with 7500 V_{rms} for 1 minute per UL1577.

Part Number	Option RoHS Compliant	Package	Surface Mount	Tape & Reel	UL 1577	IEC 60747-5-5	Quantity
ACNT-H511	-000E	15-mm Stretched SO8	X		X	X	80 per tube
	-500E		X	X	X	X	1000 per reel

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Package Outline Drawing

ACNT-H511 Stretched SO8 Package



Solder Reflow Profile

Recommended reflow conditions are as per JEDEC Standard, J-STD-020 (latest revision). Non-Halide Flux should be used.

Regulatory Information

The ACNT-H511 is approved by the following organizations:

UL	Approval under UL 1577, component recognition program up to $V_{ISO} = 7500 V_{RMS}$ File E55361.
CSA	Approval under CSA Component Acceptance Notice #5, File CA 88324.
IEC 60747-5-5	Maximum Working Insulation Voltage $V_{IORM} = 2262 V_{PEAK}$

Insulation and Safety Related Specifications

Parameter	Symbol	ACNT-H511	Units	Conditions
Minimum External Air Gap (External Clearance)	L(101)	14.2	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (External Creepage)	L(102)	15	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.5	mm	Through insulation distance conductor to conductor, usually the straight line distance thickness between the emitter and detector.
Tracking Resistance (Comparative Tracking Index)	CTI	>300	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group		IIIa		Material Group (DIN VDE 0110, 1/89, Table 1)

IEC 60747-5-5 Insulation Characteristics^a

Description	Symbol	Characteristic	Units
Installation Classification per DIN VDE 0110/39, Table 1 for rated mains voltage $\leq 600 V_{rms}$ for rated mains voltage $\leq 1000 V_{rms}$		I – IV I – IV	
Climatic Classification		40/105/21	
Pollution Degree (DIN VDE 0110/39)		2	
Maximum Working Insulation Voltage	V_{IORM}	2262	V_{peak}
Input to Output Test Voltage, Method b ^a $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	4241	V_{peak}
Input to Output Test Voltage, Method a ^a $V_{IORM} \times 1.6 = V_{PR}$, Type and Sample Test, $t_m = 10$ sec, Partial Discharge < 5 pC	V_{PR}	3619	V_{peak}
Highest Allowable Overvoltage (Transient Overvoltage $t_{ini} = 60$ sec)	V_{IOTM}	12000	V_{peak}
Safety-limiting values – Maximum Values Allowed in the Event of a Failure			
Case Temperature	T_S	150	$^{\circ}C$
Input Current	$I_{S, INPUT}$	230	mA
Output Power	$P_{S, OUTPUT}$	1000	mW
Insulation Resistance at T_S , $V_{IO} = 500V$	R_S	$>10^9$	Ω

- a. Refer to the optocoupler section of the Isolation and Control Components Designer's Catalog, under Product Safety Regulations section, (IEC 60747-5-5) for a detailed description of Method a and Method b partial discharge test profiles.

NOTE These optocouplers are suitable for "safe electrical isolation" only within the safety limit data. Maintenance of the safety limit data shall be ensured by means of protective circuits.

Absolute Maximum Ratings

Parameter	Symbol	Min.	Max.	Units
Storage Temperature	T_S	-55	125	°C
Operating Temperature	T_A	-40	105	°C
Average Forward Input Current	$I_{F(avg)}$	—	20	mA
Peak Forward Input Current ($<1 \mu s$ Pulse Width, $<10\%$ Duty Cycle)	$I_{F(peak)}$	—	80	mA
Peak Transient Input Current ($\leq 1 \mu s$ pulse width, $<300 ps$)	$I_{F(trans)}$	—	1	A
Reversed Input Voltage	V_R	—	5	V
Input Power Dissipation	P_{IN}	—	35	mW
Output Power Dissipation	P_O	—	100	mW
Output Current	I_O	—	12	mA
Supply Voltage	V_{CC}	-0.5	30	V
Output Voltage	V_O	-0.5	24	V
Lead Solder Temperature	T_{LS}	260°C for 10 sec, 1.6 mm below seating plane		
Solder Reflow Temperature Profile		Refer to Solder Reflow Profile section.		

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units
Supply Voltage	V_{CC}	4.5	24	V
Input Current, High Level	I_{FH}	10	18	mA
Operating Temperature	T_A	-40	105	°C
Forward Input Voltage (OFF)	$V_{F(OFF)}$	—	0.8	V

Electrical Specifications (DC)

Over recommended operating $T_A = -40^\circ\text{C}$ to $+105^\circ\text{C}$, supply voltage ($4.5\text{V} \leq V_{CC} \leq 24\text{V}$) and unless otherwise specified. All typical values are at $T_A = 25^\circ\text{C}$

Parameter	Symbol	Min.	Typ.	Max.	Units	Conditions			Figure
Current Transfer Ratio	CTR ^a	31	50	80	%	$T_A = 25^\circ\text{C}$	$V_O = 0.4\text{V}$	$V_{CC} = 5\text{V}$	2
		21	—	—	%		$V_O = 0.5\text{V}$	$I_F = 12\text{mA}$	
Logic Low Output Voltage	V_{OL}	—	0.2	0.4	V	$T_A = 25^\circ\text{C}$	$I_O = 3\text{mA}$	$V_{CC} = 5\text{V}$	
		—	0.2	0.5	V		$I_O = 1.6\text{mA}$	$I_F = 12\text{mA}$	
Logic High Output Current	I_{OH}	—	0.014	0.5	μA	$T_A = 25^\circ\text{C}$	$V_O = V_{CC} = 5.5\text{V}$	$I_F = 0\text{mA}$	4
		—	0.06	1			$V_O = V_{CC} = 24\text{V}$		
		—	—	80			$V_O = V_{CC} = 24\text{V}$		
Logic Low Supply Current	I_{CCL}	—	200	400	μA		$I_F = 12\text{mA}$, $V_O = \text{open}$, $V_{CC} = 24\text{V}$		
Logic High Supply Current	I_{CCH}	—	—	2	μA		$I_F = 0\text{mA}$, $V_O = \text{open}$, $V_{CC} = 24\text{V}$		
Input Forward Voltage	V_F	1.10	1.45	1.70	V		$I_F = 12\text{mA}$	1	
Input Reversed Breakdown Voltage	BV_R	7	—	—	V		$I_R = 10\mu\text{A}$		
Temperature Coefficient of Forward Voltage	$\Delta V_F / \Delta T_A$	—	-1.5	—	$\text{mV}/^\circ\text{C}$		$I_F = 12\text{mA}$		
Input Capacitance	C_{IN}	—	20	—	pF		$f = 1\text{MHz}$, $V_F = 0$		

a. Current Transfer Ratio in percent is defined as the ratio of output collector current, I_O , to the forward LED input current, I_F , times 100%.

Switching Specifications

Over recommended operating ($T_A = -40^\circ\text{C}$ to $+105^\circ\text{C}$), $I_F = 12\text{ mA}$, ($4.5\text{V} \leq V_{CC} \leq 24\text{V}$), unless otherwise specified.

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Figure
Propagation Delay Time to Logic Low at Output	T_{PHL}	—	0.1	2.0	μs	$T_A = 25^\circ\text{C}$	12
		—	—	2.0	μs		
		—	0.15	2.0	μs	$T_A = 25^\circ\text{C}$	12
		—	—	2.0	μs		
Propagation Delay Time to Logic High at Output	T_{PLH}	—	0.4	2.0	μs	$T_A = 25^\circ\text{C}$	12
		—	—	2.0	μs		
		—	0.4	2.0	μs	$T_A = 25^\circ\text{C}$	12
		—	—	2.0	μs		
Propagation Delay Difference Between Any Two Parts ^a	t _{psk}	—	0.3	2.0	μs	$T_A = 25^\circ\text{C}$	
		—	0.3	2.0	μs	$T_A = 25^\circ\text{C}$	
Common-Mode Transient Immunity at Logic High Output ^b	$ CM_H $	—	40	—	$\text{kV}/\mu\text{s}$	$T_A = 25^\circ\text{C}$	13
Common-Mode Transient Immunity at Logic Low Output ^c	$ CM_L $	—	40	—	$\text{kV}/\mu\text{s}$	$T_A = 25^\circ\text{C}$	

- The difference between t_{PLH} and t_{PHL} between any two parts under the same test condition.
- Common transient immunity in a Logic High level is the maximum tolerable (positive) dV_{CM}/dt on the rising edge of the common-mode pulse, V_{CM} , to assure that the output remains in a Logic High state.
- Common-mode transient immunity in a Logic Low level is the maximum tolerable (negative) dV_{CM}/dt on the falling edge of the common-mode pulse signal, V_{CM} to assure that the output remains in a Logic Low state.

Package Characteristics

All Typical at $T_A = 25^\circ\text{C}$.

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Input-Output Momentary Withstand Voltage ^a	V_{ISO}	7500	—	—	V_{rms}	$RH \leq 50\%$, $t = 1\text{ min.}$, $T_A = 25^\circ\text{C}$
Input-Output Resistance ^a	R_{I-O}	—	10^{14}	—	Ω	$V_{I-O} = 500\text{ Vdc}$
Input-Output Capacitance ^a	C_{I-O}	—	0.6	—	pF	$f = 1\text{ MHz}$, $T_A = 25^\circ\text{C}$

- Device considered a two terminal device: pins 2 and 3 shorted together and pins 5, 6, and 8 shorted together.

Figure 1 Input Current vs. Forward Voltage

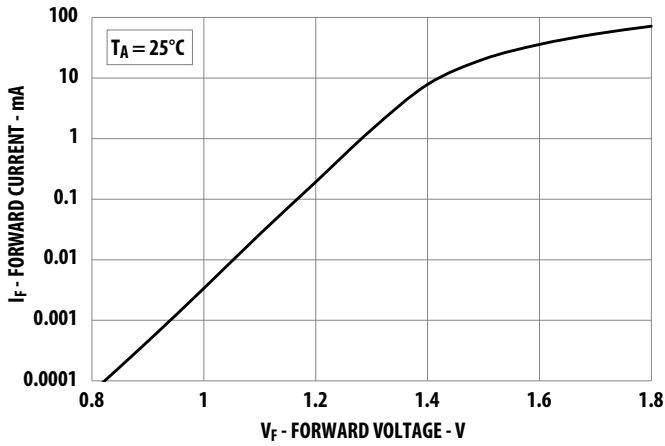


Figure 2 Typical Current Transfer Ratio vs. Temperature

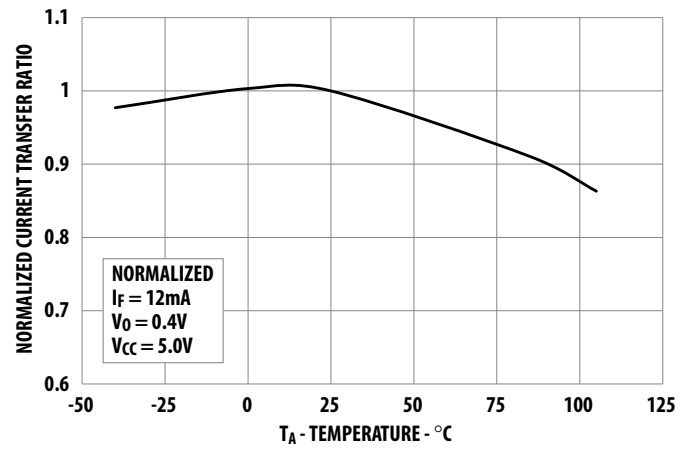


Figure 3 Typical Current Transfer Ratio vs. Temperature

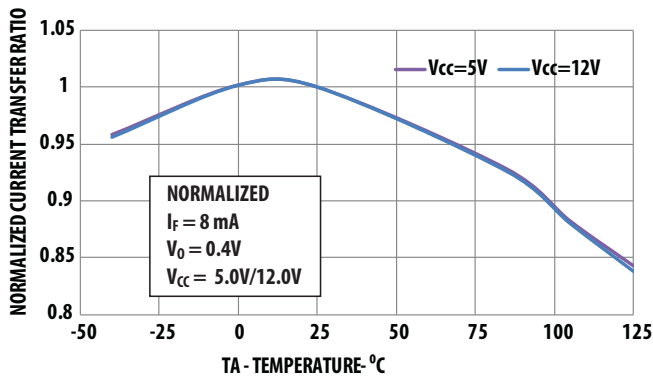


Figure 4 Typical Logic High Output Current vs. Temperature

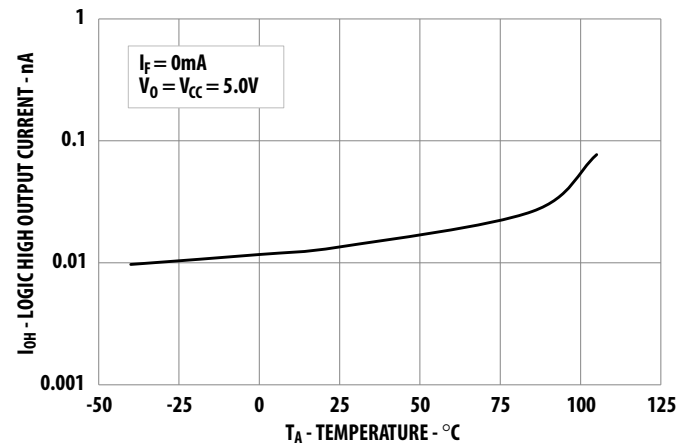


Figure 5 Typical Propagation Delay vs. Temperature

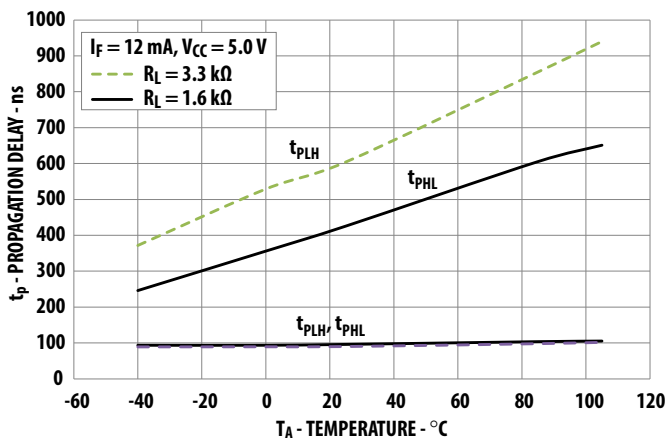


Figure 6 Typical Propagation Delay vs. Temperature

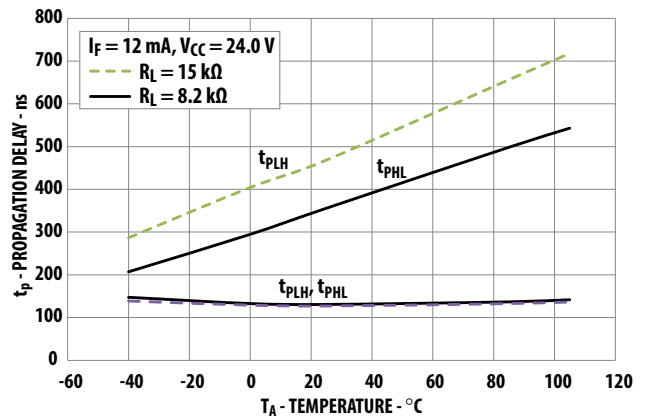


Figure 7 Typical Propagation Delay vs. Load Resistance

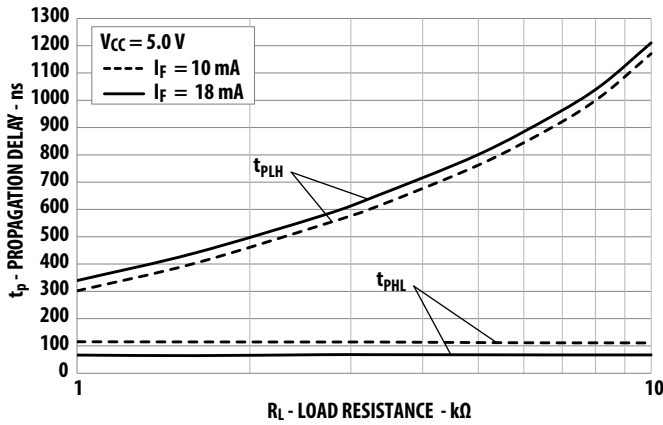


Figure 8 Typical Propagation Delay vs. Supply Voltage

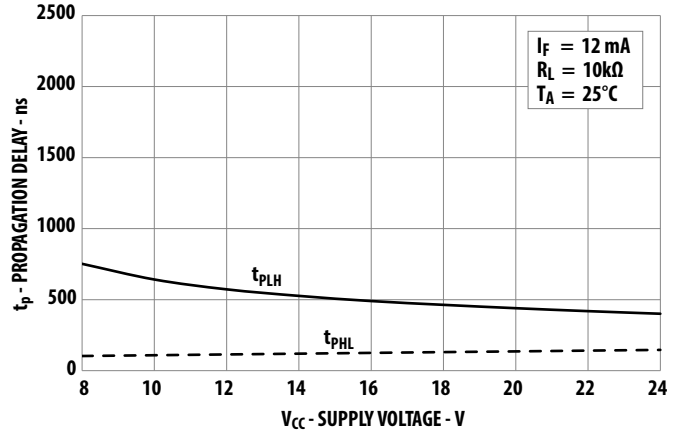


Figure 9 Typical Propagation Delay vs. Input Current

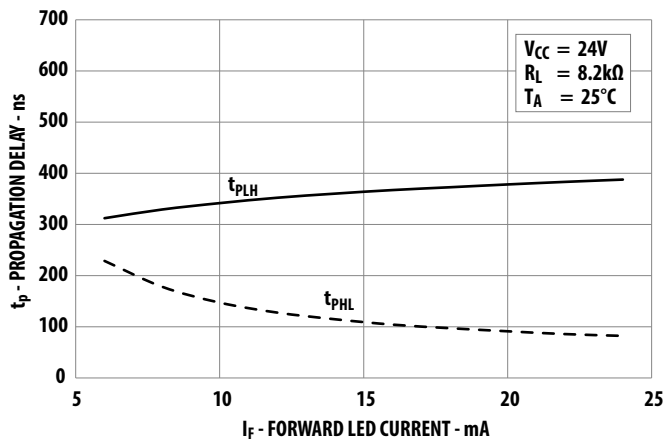


Figure 10 Current Transfer Ratio vs. Input Current

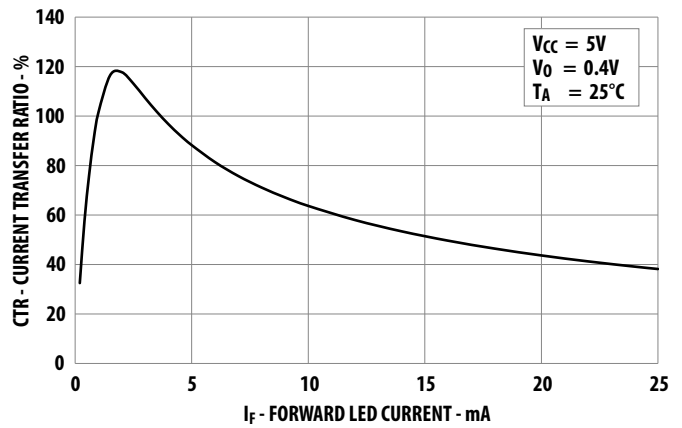
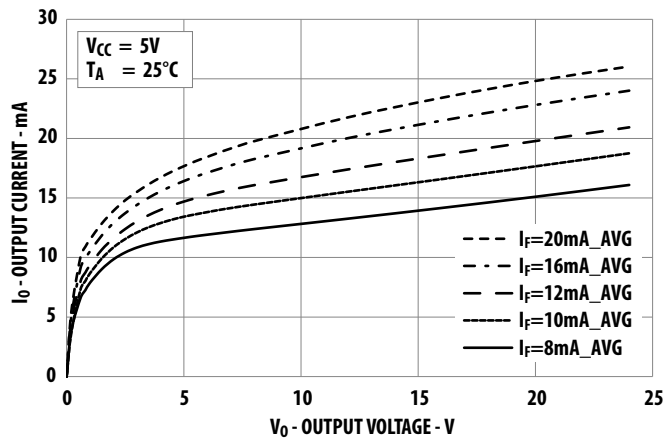


Figure 11 DC Pulse Transfer Characteristic



Test Circuits

Figure 12 Switching Test Circuits

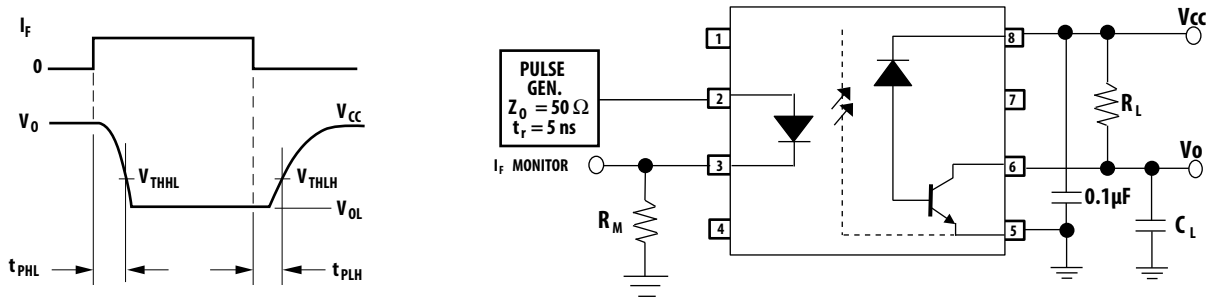


Figure 13 Test Circuit for Transient Immunity and Typical Waveforms

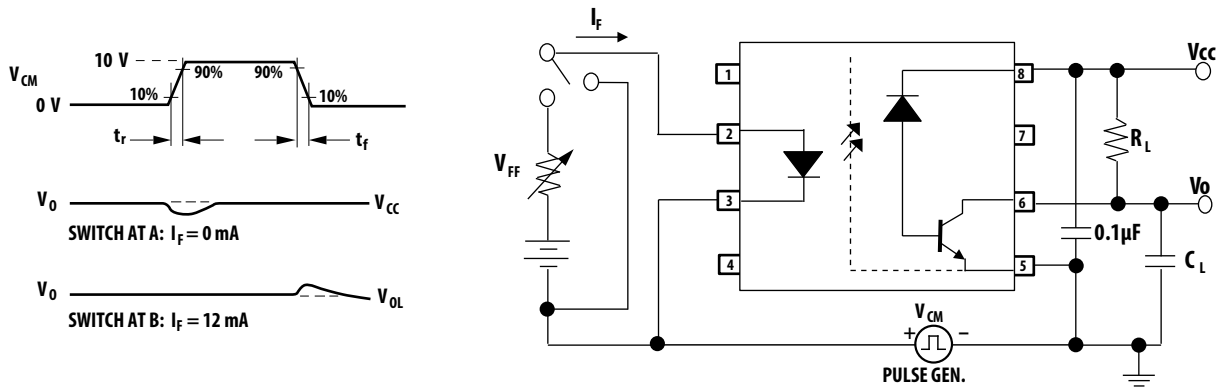


Figure 14 Output Current vs Output Voltage (4-Pin Configuration)

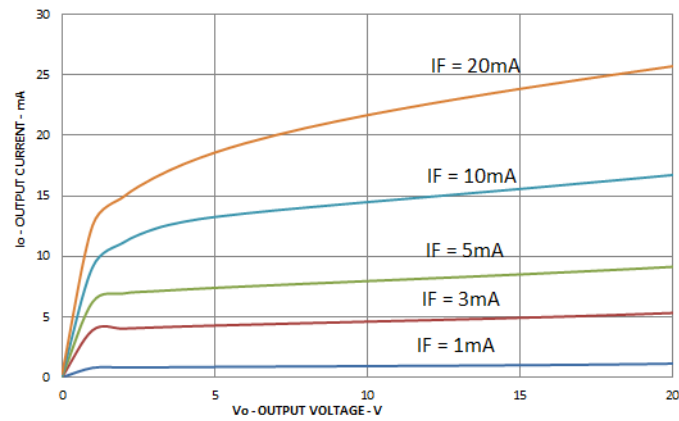
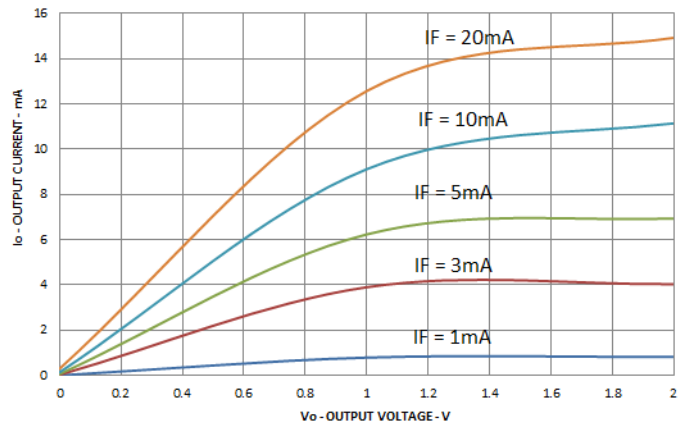


Figure 15 Low-Level Output Current vs. Output Voltage (4-Pin Configuration)



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